

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/791,256	SIDOROWICH, JOHN J.
	Examiner Sang Nguyen	Art Unit 2877

SEARCHED			
Class	Subclass	Date	Examiner
356	237.2- 237.5	11/8/2005	SN
	630		
250	559.45		
382	141		
	145		
	147		
	149		
706	13	11/8/2005	SN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner